

**Notice of References Cited**

Application/Control No.

10/577,702

Applicant(s)/Patent Under  
Reexamination  
YANAGAWA ET AL.

Examiner

Rip A. Lee

Art Unit

1713

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*	U	Andes et al. J. Am. Chem. Soc. 2001, 123, 7423-7424.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

